MINUTES FOR C37.30.4 Working Group

San Diego Oct. 2, 2012

Greetings and Introductions

The working group met on Tuesday 10/2/12. A roster is included at the end of this document. There were 8 members and 6 guests in attendance.

Old Business

A short introduction regarding the purpose of the working group was provided. Minutes of the S12 Meeting were reviewed and approved.

by reviewing the Table of Contents of IEEE 1247. In addition to the existing tests in IEEE 1247, there are some tests that need to be moved from C37.30.1 that also need to be included.

New Business

The Table of Contents of IEEE 1247 was reviewed and the sections to be included in C37.30.4 were confirmed.

It was recommended that C37.30.3 WG should review and determine the adequacy of tests previously in 1247 and not included in C37.30.4 because they are now covered in C37.100.1, C37.100.2 or other documents.

The tests to be included are switches tests (except capacitive) and fault making tests. It is intended to harmonize the test methodology with IEC to facilitate lab testing. Kirk Smith volunteered to do a comparison of TRV's for 1247 versus IEC and other

Pete Meyer and Bill Hurst will prepare a draft document for distribution prior to the next meeting. Input will be requested from test lab representatives.

Adjournment

standards.

The meeting adjourned at 3:45 PM.

Respectfully submitted,

Bill Hurst C37.30.4 Working Group Chairman

C37.30.4 Working Group

Roster

First Name	Last Name	Organization	
John Paul	Adigwu	Southern California Edison	G
Andrew	Crane	Consumers Energy	G
John	Hall	TVA	G
Kenneth	Harless	Pascor Atlantic	M
Danny	Hoss	Southern States	M
Jim	Houston	Southern Company	M - Excused
Bill	Hurst	Alstom Grid	M
Dan	Konkle	Siemens	M - Excused
Pete	Kowalik	Cleaveland Price	M
Peter	Meyer	S&C Electric	M
David	McMullen	Southern Company	M
Frank	Muench	Cooper Power	G
Carl	Reigart	Hubbell Power	M
Hugh	Ross	Ross Engineering	G
Kirk	Smith	Eaton	M
Andrew	Swisher	Southern California Edison	G